Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/780,238	WASHINGTON ET AL.	
Examiner	Art Unit	_
LIEN TM NGO	3727	

	SEARCHED			
Class	Subclass	Date	Examiner	
220	203-740	ZIPLOT	\w	
206	203-740 212 501 502			

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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